Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/825,486	LEE ET AL.
Examiner	Art Unit
Tai Duong	2871

SEARCHED								
Cla	ss	Subclass	Date		Examiner			
349		38	6/17/2006		TD			
		39						
1		43						
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		141						
		146						
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345 438		92						
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INTERFERENCE SEARCHED							
Subclass	Date	Examiner					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
DATE	EXMR					
6/17/2006	DΤ					
	DATE					